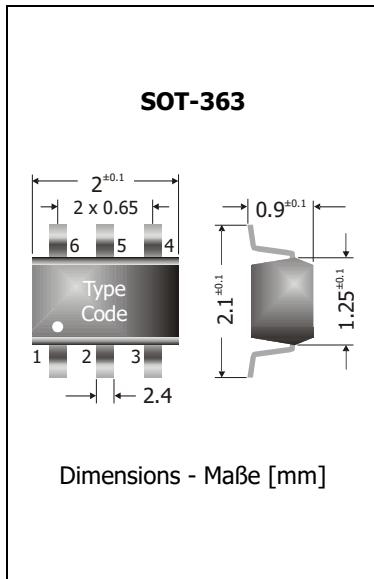


|  |                                    |                                 |
|--|------------------------------------|---------------------------------|
| <b>BAS16DW, BAV70DW, BAV756DW, MMBD4448SDW</b><br><b>SMD Small Signal Diode Arrays</b><br><b>SMD Kleinsignal-Dioden-Arrays</b> | <b>I<sub>FAV</sub> = 150 mA</b>    | <b>V<sub>RRM</sub> = 75 V</b>   |
|  | <b>V<sub>F1</sub> &lt; 0.715 V</b> | <b>I<sub>FSM1</sub> = 2 A</b>   |
|  | <b>T<sub>jmax</sub> = 150°C</b>    | <b>t<sub>rr</sub> &lt; 4 ns</b> |

Version 2018-08-30



**Typical Applications**

Signal processing, High-speed Switching, Rectifying  
 Commercial grade  
 Suffix -Q: AEC-Q101 compliant <sup>1)</sup>  
 Suffix -AQ: in AEC-Q101 qualification <sup>1)</sup>

**Features**

Very low t<sub>rr</sub>, C<sub>j</sub> and I<sub>R</sub>  
 Compliant to RoHS, REACH, Conflict Minerals <sup>1)</sup>

**Mechanical Data <sup>1)</sup>**

Taped and reeled  
 Weight approx.  
 Case material  
 Solder & assembly conditions

**Typische Anwendungen**

Signalverarbeitung, Schnelles Schalten, Gleichrichten  
 Standardausführung  
 Suffix -Q: AEC-Q101 konform <sup>1)</sup>  
 Suffix -AQ: in AEC-Q101 Qualifikation <sup>1)</sup>

**Besonderheiten**

Sehr niedriges t<sub>rr</sub>, C<sub>j</sub> und I<sub>R</sub>  
 Konform zu RoHS, REACH, Konfliktmineralien <sup>1)</sup>

**Mechanische Daten <sup>1)</sup>**

3000 / 7"  
 0.01 g  
 UL 94V-0  
 260°C/10s  
 MSL = 1  
 Gegurtet auf Rolle  
 Gewicht ca.  
 Gehäusematerial  
 Löt- und Einbaubedingungen

|  |  |
|--|--|
| <p><b>BAS16DW/-AQ</b></p> <p>3 Single Diodes</p> <p>Type Code KW</p> <p>1, 2, 3 = A 4, 5, 6 = C</p>  | <p><b>BAV70DW</b></p> <p>2 x 2 Common Cathode</p> <p>Type Code A4</p> <p>1 = A1, 2 = A2, 3 = C3/C4<br/>             4 = A3, 5 = A4, 6 = C1/C2</p>      |
| <p><b>BAV756DW</b></p> <p>2 x 2 Common Cathode/Anode</p> <p>Type Code B7</p> <p>1 = A1, 2 = C2, 3 = A2/A3<br/>             4 = C3, 5 = A4, 6 = C1/C4</p> | <p><b>MMBD4448SDW</b></p> <p>4 in Bridge Configuration</p> <p>Type Code KB</p> <p>1 = A1, 2 = C1, 3 = AC2<br/>             4 = A2, 5 = C2, 6 = AC1</p> |

**Maximum ratings <sup>2)</sup>**

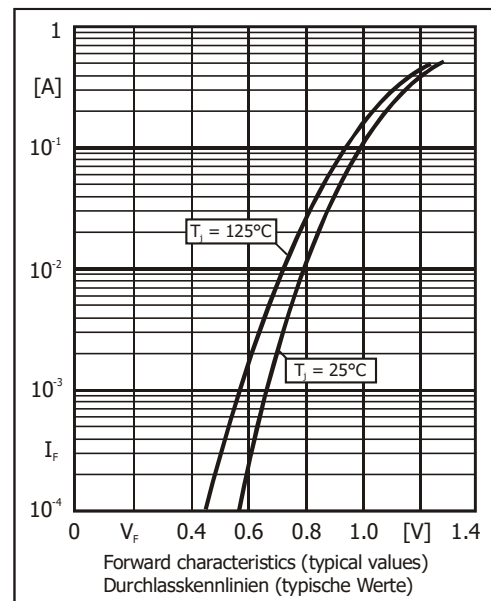
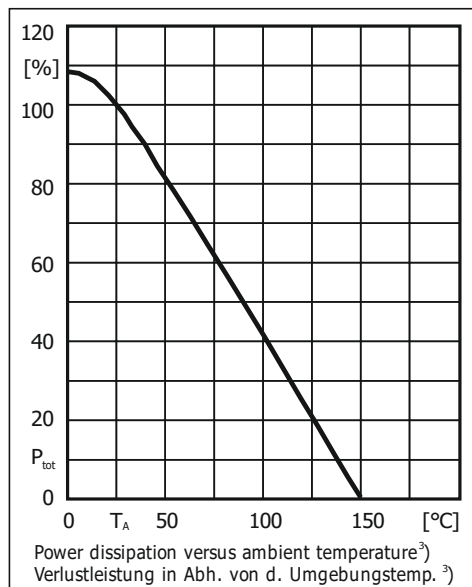
**Grenzwerte <sup>2)</sup>**

|  |   |                       |
|--|---|-----------------------|
| Power dissipation (per device) – Verlustleistung (pro Bauteil)       | P <sub>tot</sub>  | 200 mW <sup>3)</sup>  |
| Maximum average forward current – Dauergrenzstrom                    | I <sub>FAV</sub>  | 150 mA <sup>3)</sup>  |
| Repetitive peak forward current – Periodischer Spitzenstrom          | I <sub>FRM</sub>  | 300 mA <sup>3)</sup>  |
| Peak forward surge current<br>Stoßstrom in Fluss-Richtung            | t <sub>p</sub> ≤ 1 s<br>t <sub>p</sub> ≤ 1 µs<br>I <sub>FSM</sub>   | 0.5 A<br>2 A          |
| Repetitive peak reverse voltage<br>Periodische Spitzensperrensorgung | MMBD4448SDW, BAS16DW/-AQ<br>BAV756DW<br>BAV70DW<br>V <sub>RRM</sub> | 75 V<br>90 V<br>100 V |
| Junction/ Storage temperature – Sperrschicht-/Lagerungstemperatur    | T <sub>j/S</sub>  | -55...+150°C          |

1 Please note the [detailed information on our website](#) or at the beginning of the data book  
 Bitte beachten Sie die [detaillierten Hinweise auf unserer Internetseite](#) bzw. am Anfang des Datenbuches  
 2 T<sub>A</sub> = 25°C and per diode, unless otherwise specified – T<sub>A</sub> = 25°C und pro Diode, wenn nicht anders angegeben  
 3 Mounted on 3 mm<sup>2</sup> copper pads per terminal – Montage auf 3 mm<sup>2</sup> Kupferbelag (Löt pads) je Anschluss

**Characteristics**
**Kennwerte**

|   |  |                  |                  | BAS16DW/<br>-AQ | BAV70DW<br>BAV756DW | MMBD4448SDW    |
|---|--|------------------|------------------|-----------------|---------------------|----------------|
| Forward voltage<br>Durchlass-Spannung<br>1)<br>T <sub>j</sub> = 25°C              | I <sub>F</sub> =   | 1 mA             | V <sub>F</sub>   | < 715 mV        | < 715 mV            | –              |
|   |  | 5 mA             |                  | –               | –                   | 620 ... 720 mV |
|   |  | 10 mA            |                  | < 855 mV        | < 855 mV            | < 855 mV       |
|   |  | 50 mA            |                  | < 1.0 V         | < 1.0 V             | –              |
|   |  | 100 mA           |                  | –               | –                   | < 1.0 V        |
|   |  | 150 mA           | < 1.25 V         | < 1.25 V        | < 1.25 V            |                |
| Leakage current<br>Sperrstrom<br>1)   | T <sub>j</sub> = 25°C  | V <sub>R</sub> = | I <sub>R</sub>   | 20 V            | –                   | < 25 nA        |
|   |  |                  |                  | 25 V            | < 30 nA             | –              |
|   |  |                  |                  | 75 V            | –                   | –              |
|   |  |                  |                  | 80 V            | < 0.5 µA            | < 100 nA       |
|   | T <sub>j</sub> = 150°C   | 25 V             | I <sub>R</sub>   | < 30 µA         | –                   | < 30 µA        |
|   |  | 75 V             | I <sub>R</sub>   | < 50 µA         | < 30 µA             | < 50 µA        |
|   |  | 80 V             | I <sub>R</sub>   | –               | < 100 µA            | –              |
| Junction capacitance<br>Sperrschichtkapazität                                     | V <sub>R</sub> = 0 V, f = 1 MHz  |                  | C <sub>T</sub>   | typ. 2 pF 2)    |                     |                |
| Reverse recovery time<br>Sperrverzug  | I <sub>F</sub> = 10 mA über/through<br>I <sub>R</sub> = 10 mA bis/to I <sub>R</sub> = 1 mA |                  | t <sub>rr</sub>  | < 4 ns 2)       |                     |                |
| Thermal resistance junction to ambient<br>Wärmewiderstand Sperrschicht – Umgebung |  |                  | R <sub>thA</sub> | < 400 K/W 3)    |                     |                |



**Disclaimer:** See data book page 2 or [website](#)  
**Haftungsausschluss:** Siehe Datenbuch Seite 2 oder [Internet](#)

- 1 Tested with pulses t<sub>p</sub> = 300 µs, duty cycle ≤ 2%  
Gemessen mit Impulsen t<sub>p</sub> = 300 µs, Schaltverhältnis ≤ 2%
- 2 Valid per diode – Gültig pro Diode
- 3 Mounted on 3 mm<sup>2</sup> copper pads per terminal  
Montage auf 3 mm<sup>2</sup> Kupferbelag (Löt pads) je Anschluss